

T E S T R E P O R T No.: 19-1-0067201T07a

> According to: FCC Regulations §1.1310 § 2.1091 & 2.1093

for Continental Automotive GmbH

D-WMI2020B

# FCC-ID: KR5DWMI2020B

Laboratory Accreditation
Deutsche De-P-12047-01-01 D-P-12047-01-03 D-PL-12047-01-04
accredited according to DIN EN ISO/IEC 17025
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The listed attachments are an integral part of this report.



# 1. Summary of test results

The test results apply exclusively to the test samples as presented in this Report. The CETECOM GmbH does not assume responsibility for any conclusions and generalizations taken in conjunction with other specimens or samples of the type of the item presented to tests.

The Equipment Under Test (in this report, hereinafter referred as EUT) is a wireless charger. The charger is operated at Carrier Frequency 127,7 kHz

No. of Diagra	Test	Port	References, S Limits	Standards &	EUT	EUT op-	Result	
m group	Cases	1 010	FCC	Limits	set-up	mode		
1.1	Electric field strength	6.2 cm distance to EUT (surround the edge of Device)	§1.1310 §2.1091 §2.1093	614 (V/m)	1	1+2+3	passed	
1.1	Electric field strength	7.3 cm distance to EUT (top side of Device)	§1.1310 §2.1091 §2.1093	614 (V/m)	1	1+2+3	passed	
1.2	Magnetic field strength	6.2 cm distance to EUT (surround the edge of Device)	§1.1310 §2.1091 §2.1093	1.63 (A/m)	1	1+2+3	Passed	
1.2	Magnetic field strength	7.3 cm distance to EUT (top side of Device)	\$1.1310 \$2.1091 \$2.1093	1.63 (A/m)	1	1+2+3	Passed	
1.1	Electric field strength	6.2 cm distance to EUT (surround the edge of Device)	\$1.1310 \$2.1091 \$2.1093	614 (V/m)	2	1+2+3	passed	
1.1	Electric field strength	7.3 cm distance to EUT (top side of Device)	\$1.1310 \$2.1091 \$2.1093	614 (V/m)	2	1+2+3	passed	
1.2	Magnetic field strength	6.2 cm distance to EUT (surround the edge of Device)	§1.1310 §2.1091 §2.1093	1.63 (A/m)	2	1+2+3	Passed	
1.2	Magnetic field strength	7.3 cm distance to EUT (top side of Device)	§1.1310 §2.1091 §2.1093	1.63 (A/m)	2	1+2+3	Passed	

#### TEST OVERVIEW

Remark:

Following tests have been performed to show compliance with applicable Standards:

FCC §1.1310, §2.1091 §2.1093

OET Bulletin 65 Supplement C KDB 680106 D01 V03.

deviating to KDB 680106 D01 V03 tests were performed due to customer declaration with 6.2cm distance between edge of EUT and probe and 7.3 cm between top of EUT and probe.

Dipl.-Ing. Markus Ridder Responsible for test section

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W. Markus Responsible for test report

.....



# 2. Administrative Data

# 2.1. Identification of the testing laboratory

Responsible for testing laboratory:Volker WittmannDeputy for testing laboratory:DiplIng. Niels Jeß	Company name: Address:	CETECOM GmbH Im Teelbruch 116 45219 Essen - Kettwig Germany	
Deputy for testing laboratory: DiplIng. Niels Jeß	Responsible for testing laboratory:	Volker Wittmann	
	Deputy for testing laboratory:	DiplIng. Niels Jeß	

#### **2.2. Test location 2.2.1. Test laboratory "CTC"**

Company name:	see chapter 2.1. Identification of the testing laboratory

# 2.3. Organizational items

Responsible for test report:	W. Markus	
Receipt of EUT:	2019-05-09	
Date(s) of test:	2019-07-31	
Date of report:	2019-09-18	
Date of report:	2019-09-18	
Version of template: 12.11		

## 2.4. Applicant's details

Applicant's name:	Continental Automotive GmbH
Address:	Siemensstrasse 12 93055, Regensburg Germany
Contact person:	Ms. Qian Liu

## 2.5. Manufacturer's details

Manufacturer's name:	Continental Automotive Lithuania UAB
Address:	Davalgonių g. 12 LT-54462 Sergeičikai I, Kaunas region Lithuania
2nd Plant: Manufacturer's name:	Continental Automotive Systems (Tianjin) Co. Ltd.
Address:	No. 2 Bohai Road 300457 TEDA Tianjin P.R. China

## 2.6. Customer's details

Customer's name:	IB-Lenhardt AG	
Address:	Heinrich-Hertz-Allee 7 66386, St. Ingbert Germany	
Contact person:	Philipp Gräf	



# **3.** Equipment under test (EUT)

## 3.1. Technical data of main EUT declared by applicant

Main function	Wireless power Charger				
Туре	D-WMI2020B (high and low Version	n)			
Carrier Frequency	127.7 kHz				
Max. nominal power	15 W				
Antenna Type	Single coil according to Qi standard				
Power supply	🗵 13.5 V DC				
Special EMI components					
EUT sample type					
FCC-ID:	KR5DWMI2020B				
FCC label attached	🗆 yes 🗷 no				

## 3.2. EUT: Type, S/N etc. and short descriptions used in this test report

Short descrip- tion*)	EUT	Туре	S/N serial number	HW hardware status	SW software status
EUT A (S12)	D-WMI2020B	Wireless Power Charger (high Version)	A2C16629105 00 19 04 10 0028	C2	19.09.30
EUT B (S08)	D-WMI2020B	Wireless Power Charger (low version)	A2C16629105 00 19 04 10 0026	C2	19.09.30

\*) EUT short description is used to simplify the identification of the EUT in this test report.

## 3.3. Auxiliary Equipment (AE): Type, S/N etc. and short descriptions

AE short descrip- tion *)	Auxiliary Equipment	Туре	S/N serial number	HW hardware status	SW software status
AE 1	Power Cable				
AE 2	Qi Receiver Simulator	AVID 15 W, 102-03		V1.2	

\*) AE short description is used to simplify the identification of the auxiliary equipment in this test report.

## 3.4. EUT set-ups

EUT set-up no.*)	Combination of EUT and AE	Remarks
Set. 1	EUT A + AE 1 + AE 2	
Set. 2	EUT B + AE 1 + AE 2	

\*) EUT set-up no. is used to simplify the identification of the EUT set-up in this test report.



# **3.5. EUT operating modes**

EUT operating mode no.*)	Description of operating modes	Additional information
op. 1	Wireless charging	Wireless charging was activated. The EUT is transferring power to AE2 With 900 mA LOAD (90% charging level)
op. 2	Wireless charging	Wireless charging was activated. The EUT is transferring power to AE2 with 500 mA LOAD (50%charging level)
op. 3	Wireless charging	Wireless charging was activated. The EUT is transferring power to AE2 with 100 mA LOAD (5% charging level)

\*) EUT operating mode no. is used to simplify the test report.

Less than 5% charging level is not possible due to technical reasons with the Qi Receiver Simulator

# 3.6. Additional declaration and description of EUT

	□ table-top □ floor-standing	typical use □ portable use		
Set up 1	$\Box$ wall-mounted $\Box$ fixed use			
	■ not defined ■ Inted use			
	□ Residential, commercial and light			
Place of use	□ Industrial environment	5		
	🗷 vehicular use			
typical operating cycle of EUT	$\square$ < 0.5 sec. $\square$ :			
Power line:	EUT-grounding:			
□ AC □ 120 V, □ 230 V, □ 400 V	x none			
$\Box$ PE, $\Box$ N, $\Box$ L1, $\Box$ L2 $\Box$ L3	□ with power supply			
□ _ Hz	additional:			
☑ DC ☑ 13.5V	(in case of deviation during tests the single details are described on chapter 4)			
Other Ports (description of interconnecting cables)		.1.1.1.1	connected	
Description	possible total cable length	shielding	during test	
1 Power Line	<b>⊠</b> < 3 m □> 3 m	□ screened	🗴 yes	
I Power Line		🗷 unscreened	🗆 no	
Does EUT contain devices susceptible to magnetic fields, e.g. Hall elements, electrodynamics				
Does EUT contain devices susceptible to magnetic fields, e.g. Hall elements, electrodynamics incrophones, etc.?				
Is mounting position / usual operating position defined?				



# 4. DESCRIPTION OF TEST SET-UP's

## 4.1. Test Set-up for configuration

The RF exposure test is performed in shielded room.

The EUT was placed on a table.

The measurement probe was surrounding point 1 to point 4 at a distance of 6.2 cm from the EUT and 7.3 cm above the top surface (point 5) for H-field and E-filed strength

The distances were declared as the worst case by the customer

EUT A:

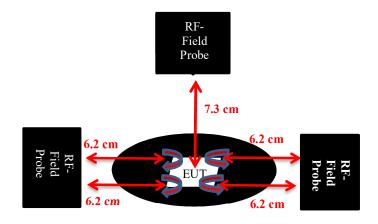


EUT B:





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Schematic: Test set-up for RF exposure measurements

Measurement for E-Field with NBM550 + EF 0391 probe Measurement for H-Field with ELT 400 + ELT probe  $100cm^2$ 



# 5. Maximum Permissible RF Exposure

5.1.FCC References & Limits

FCC Rules: §1.1310, § 2.1093

The criteria used for the evaluation of human exposure to radio frequency radiation is listed in table 1 according FCC \$1.1307(b, except in the case of portable devices which shall be evaluated according to the provisions of <math>\$2.1093 of this.

Note 1 to table 1: Occupational/controlled limits apply in situations in which persons are exposed as a consequence of their employment provide those persons are fully aware for a exposure and can control over their exposure. Limits for occupational/controlled exposures also apply in situations when an individual is transient through a location where occupational/controlled apply provided he or she is made aware of the potential for exposure.

Note 2 to table 1: General population/uncontrolled exposures apply in situations in which the general public may be exposed, or which persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or cannot exercise control over their exposure.

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
30–300 300–1500 1500–100,000	61.4	0.163	1.0 f/300 5	6 6 6

(B) Limits for General Population/Uncontrolled Exposure

	•			
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f <sup>2</sup> )	30
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500–100,000			1.0	30

f = frequency in MHz

So applicable limits in this case are as follows:

§1.1310 LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE) Table 1(B) Limits for General Population/Uncontrolled Exposure

0.3–1,34 MHz: Electric field: 614 V/m

0.3-1,34 MHz: Magnetic field: 1.63 A/m



## **5.2.** E-Field Results

#### 5.2.1. Test location and equipment (for reference numbers please see chapter 'List of test equipment')

test location	CETECOM Esser	n (Chapter 2.2.1)	Dease see Chapt	er 2.2.2	□ Please see Chapt	ter 2.2.3
equipment	🗷 NBM 550	🗷 EF 0391				
signaling	017 CMD 65	□ 323 CMD 55	□ 340 CMD 55			
signaling	□ 298 CMU	□ 460 CMU	295 RACAL	□ 392 MT8820A		
line voltage	🗷 13.5 V DC					

#### 5.2.2. Test condition and test set-up

cizizi i est condition and test set a	P		
link to test system (if used):	🗆 air link	□ cable connection	
EUT-grounding (if different to chapter 3.5)	🗆 none	□ with power supply	additional connection
Equipment set up	-		-
Climatic conditions	Temperatur	re: 24 °C	Rel. humidity: 31 % rH

#### 5.2.3. Results

## Table 1:

# The aggregate E-Field strengths at 6.2 cm surrounding the device:

EUT Type and S/N or EUT set-up no.			Se	t- up 1
EUT operating mode or operating mode no.		EUT operating mode 1 (5% charging level)		
Frequency		Distance between	E-field	E-field
Range	Position	EUT and Field	(V/m)	Limit
$(l_{\tau}\mathbf{H}_{\tau})$		probe		(V/m)
(kHz)		(m)		
127.5	1	0.062	7.13	614
127.5	2	0.062	7.31	614
127.5	3	0.062	7.52	614
127.5	4	0.062	7.81	614

Remarks:

EUT Type and S/N or EUT set-up no.			Se	t- up 1
EUT operating mode or operating mode no.		EUT operating mode 2 (50% charging level)		
Frequency		Distance between	E-field	E-field
Range	Position	EUT and Field	(V/m)	Limit
(HII-)		probe		(V/m)
(kHz)		(m)		
127.5	1	0.062	2.02	614
127.5	2	0.062	2.14	614
127.5	3	0.062	2.41	614
127.5	4	0.062	2.38	614

Remarks:

EUT Type a	nd S/N or H	EUT set-up no.	Se	t- up 1
EUT operating mode or operating mode no.		EUT operating mode 3 (90% charging level)		
Frequency		Distance between	E-field	E-field
Range	Position	EUT and Field	(V/m)	Limit
$(l_{2}\mathbf{U}_{2})$	Position	probe		(V/m)
(kHz)		(m)		
127.5	1	0.062	1.91	614
127.5	2	0.062	1.95	614
127.5	3	0.062	1.99	614
127.5	4	0.062	2.07	614

Remarks:



EUT Type and S/N or EUT set-up no.		Set- up 2		
EUT operating mode or operating mode no.		EUT operating mode 1 (5% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)
127.5	1	0.062	6.71	614
127.5	2	0.062	6.82	614
127.5	3	0.062	6.94	614
127.5	4	0.062	7.31	614

Remarks:

EUT Type a	nd S/N or I	EUT set-up no.	Set- up 2		
EUT operating operating	g mode or g mode no.		EUT operating mode 2 (50% charging level)		
Frequency		Distance between	E-field	E-field	
Range	Position	EUT and Field	(V/m)	Limit	
(1.11)	Position	probe		(V/m)	
(kHz)		(m)			
127.5	1	0.062	2.00	614	
127.5	2	0.062	2.10	614	
127.5	3	0.062	2.29	614	
127.5	4	0.062	2.35	614	

Remarks:

EUT Type an	nd S/N or H	EUT set-up no.	Set- up 2		
	g mode or g mode no.		EUT operating mode 3 (90% charging level)		
Frequency	uency Distance between		E-field	E-field	
Range	Position	EUT and Field	(V/m)	Limit	
(kHz)	rosition	probe		(V/m)	
(KIIZ)		(m)			
127.5	1	0.062	1.90	614	
127.5	2	0.062	1.92	614	
127.5	127.5 3 0.062		1.95	614	
127.5	4	0.062	2.00	614	

Remarks:



# Table 2:The aggregate E-Field strengths at 7.3 cm above the top of the device:

EUT Type and S/N or EUT set-up no.			Set- up 1		
	g mode or g mode no.		EUT operating mode 1 (5% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)	
127.5	5	0.073	15.65	614	

Remarks:

EUT Type and S/N or EUT set-up no.			Set- up 1		
EUT operating mode or operating mode no.		EUT operating mode 1 (50% charging level)			
Frequency Range	Position	Distance between EUT and Field	E-field (V/m)	E-field Limit	
(kHz)	1 obtion	probe (m)		(V/m)	
127.5	5	0.073	11.87	614	

Remarks:

EUT Type an	nd S/N or I	EUT set-up no.	Set- up 1		
EUT operating mode or operating mode no.		EUT operating mode 1 (90% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)	
127.5	5	0.073	3.02	614	

Remarks:

EUT Type an	nd S/N or H	EUT set-up no.	Set- up 2		
	g mode or g mode no.		EUT operating mode 1 (5% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)	
127.5	5	0.073	14.50	614	

Remarks:

EUT Type and S/N or EUT set-up no.			Set- up 2		
EUT operating operating	g mode or g mode no.		EUT operating mode 1 (50% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)	
127.5	5	0.073	11.39	614	

Remarks:

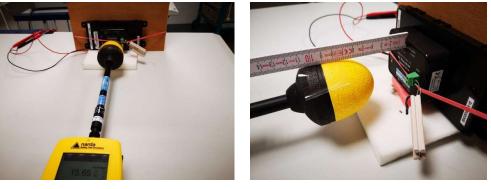


EUT Type and S/N or EUT set-up no.			Set- up 2		
EUT operating mode or operating mode no.		EUT operating mode 1 (90% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	E-field (V/m)	E-field Limit (V/m)	
127.5	5	0.073	2.91	614	

Remarks:

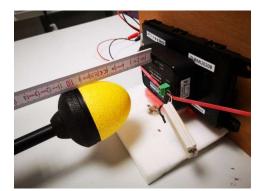
Max E-Field, 7.3 cm distance between EUT and probe (top side)

EUT A:



EUT B:







## **5.3.** H-Field Results

#### **5.3.1. Test location and equipment** (for reference numbers please see chapter 'List of test equipment')

test location	CETECOM Essen (Chapter 2.2.1)		□ Please see Chapter 2.2.2		□ Please see Chapter 2.2.3	
equipment	🗷 802 ELT400	■ 803 ELT probe 3cm <sup>2</sup>				
signaling	017 CMD 65	□ 323 CMD 55	□ 340 CMD 55			
signaling	□ 298 CMU	□ 460 CMU	□295 RACAL	□ 392 MT8820A		
line voltage	🗵 13.5 V DC					

#### 5.3.2. Test condition and test set-up

link to test system (if used):		air link		cable connection	1
EUT-grounding (if different to chapter 3.5)		none		with power supply	bly 🔲 additional connection
Equipment set up	-				-
Climatic conditions	Ter	mperatur	e: 2	24 °C	Rel. humidity: 31 % rH

#### Table 4:

## The aggregate H-Field strengths at 6,2cm surrounding the device:

EUT Type	e and S/N or	EUT set-up no		Set-up 1			
EUT operating mode or operating mode no.			EUT operating mode 1 (5% charging level)				
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result		
127.5	1	0.062	0.72	1.63	passed		
127.5	2	0.062	0.75	1.63	passed		
127.5	3	0.062	0.78	1.63	passed		
127.5	4	0.062	0.83	1.63	passed		

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

EUT Type	e and S/N or	EUT set-up no.		Set-up 1	
EUT operating mode or operating mode no.			EUT operating mode 2 (50% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	1	0.062	0.69	1.63	passed
127.5	2	0.062	0.71	1.63	passed
127.5	3	0.062	0.76	1.63	passed
127.5	4	0.062	0.80	1.63	passed

Remarks: Measurement values were transformed from  $\mu T$  to A/m, where 1 A/m = 1.256  $\mu T$ 

EUT Type	e and S/N or	EUT set-up no.	Set-up 1		
EUT operating mode or operating mode no.			EUT operating mode 3 (90% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	1	0.062	0.58	1.63	passed
127.5	2	0.062	0.61	1.63	passed
127.5	3	0.062	0.64	1.63	passed
127.5	4	0.062	0.70	1.63	passed

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T



EUT Type	e and S/N or	EUT set-up no	Set-up 2		
EUT operating mode or operating mode no.			EUT operating mode 1 (5% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	1	0.062	0.57	1.63	passed
127.5	2	0.062	0.60	1.63	passed
127.5	3	0.062	0.65	1.63	passed
127.5	4	0.062	0.71	1.63	passed

Remarks: Measurement values were transformed from  $\mu T$  to A/m, where 1 A/m = 1.256  $\mu T$ 

EUT Type and S/N or EUT set-up no.				Set-up 2		
EUT operating mode or operating mode no.				EUT operating mode 2 (50% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result	
127.5	1	0.062	0.61	1.63	passed	
127.5	2	0.062	0.65	1.63	passed	
127.5	3	0.062	0.66	1.63	passed	
127.5	4	0.062	0.73	1.63	passed	

Remarks: Measurement values were transformed from  $\mu T$  to A/m, where 1 A/m = 1.256  $\mu T$ 

EUT Type	e and S/N or	EUT set-up no.	Set-up 2			
EUT operating mode or operating mode no.			EUT operating mode 3 (90% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result	
127.5	1	0.062	0.45	1.63	passed	
127.5	2	0.062	0.51	1.63	passed	
127.5	3	0.062	0.52	1.63	passed	
127.5	4	0.062	0.58	1.63	passed	

Remarks: Measurement values were transformed from  $\mu T$  to A/m, where 1 A/m = 1.256  $\mu T$ 



# Table 5:The aggregate H-Field strengths at 7.3 cm above the top of the device:

				<u> </u>		
EUT Type	e and S/N or	EUT set-up no.	Set-up 1			
EUT operating mode or operating mode no.			EUT operating mode 1 (5% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result	
127.5	5	0.073	1.61	1.63	passed	

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

EUT Type and S/N or EUT set-up no.			Set-up 1			
EUT operating mode or operating mode no.			EUT operating mode 2 (50% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result	
127.5	5	0.073	1.56	1.63	passed	

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

EUT Type	e and S/N or	EUT set-up no.	Set-up 1		
EUT operating mode or operating mode no.			EUT operating mode 3 (90% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	5	0.073	1.43	1.63	passed

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

EUT Type	e and S/N or	EUT set-up no.	Set-up 2			
EUT operating mode or operating mode no.			EUT operating mode 1 (5% charging level)			
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result	
127.5	5	0.073	1.56	1.63	passed	

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

EUT Type	e and S/N or	EUT set-up no.	Set-up 1		
EUT operating mode or operating mode no.			EUT operating mode 2 (50% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	5	0.073	1.44	1.63	passed

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T



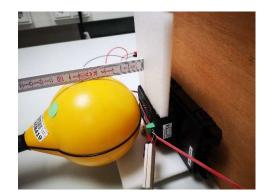
EUT Type	e and S/N or	EUT set-up no.	Set-up 1		
EUT operating mode or operating mode no.			EUT operating mode 3 (90% charging level)		
Frequency Range (kHz)	Position	Distance between EUT and Field probe (m)	H-field (A/m)	H-field Limit (A/m)	Result
127.5	5	0.073	1,30	1.63	passed

Remarks: Measurement values were transformed from  $\mu$ T to A/m, where 1 A/m = 1.256  $\mu$ T

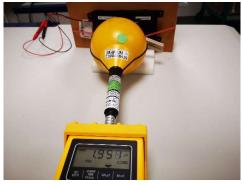
Max H-Field, 9.7 cm Distance between EUT and probe (top side)

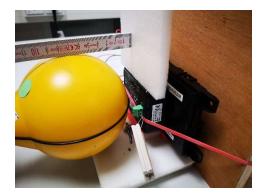
EUT A:





EUT B:







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Max H-Field, 6.2 cm Distance between EUT and probe (edge of the device, Point 4)



EUT B:





# 6. Measurement uncertainties

The reported uncertainties are calculated based on the standard uncertainty multiplied with the appropriate coverage factor  $\mathbf{k}$ , such that a confidence level of approximately 95% is achieved.

For uncertainty determination, each component used in the concrete measurement set-up was taken in account and it's contribution to the overall uncertainty according it's statistical distribution calculated.

RF-Measurement	Frequency range	Calculated uncertainty based on a confidence level of 95%	Remarks:
Power Output conducted	9 kHz 20 GHz	1.0 dB	
Power Output radiated	30 MHz 4 GHz	3.17 dB	Substitution method
Conducted emissions on antenna ports	9 kHz 20 GHz	1.0 dB	
	9 kHz 30 MHz	5.0 dB	Magnetic field
Radiated emissions enclosure	9 MHz 1 GHz	5.0 dB	E-Field
Radiated emissions enclosure	30 MHz 1 GHz	4.2 dB	E-Field
	1 GHz 20 GHz	3.17 dB	Substitution method
Occupied bandwidth	9 kHz 4 GHz	0.1272 ppm (Delta Marker )	Frequency error
occupied ballawidth		1.0 dB	Power
Emission bandwidth	9 kHz 4 GHz	0.1272 ppm (Delta Marker)	Frequency error
		1.0 dB	Power
Frequency stability	9 kHz 20 GHz	0.0636 ppm	
Conducted emissions	9 kHz 150 kHz	4.0 dB	
on AC-mains port (UCISPR)	150 kHz 30 MHz	3.6 dB	

Following table shows expectable uncertainties for each measurement type performed.

Table: measurement uncertainties, valid for conducted/radiated measurements

# 7. Accreditation details of CETECOM's laboratories and test sites

Ref No.	Accreditation Certificate	Valid for laboratory area or test site	Accreditation Body
-	D-PL- 12047-01-01	All laboratories and test sites of CETECOM GmbH, Essen	DAkkS, Deutsche Akkreditierungsstelle GmbH
337 487 558 348 348	MRA US-EU 0003	Radiated Measurements 30 MHz to 1 GHz, 3 m / 10 m (OATS) Radiated Measurements 30 MHz to 1 GHz, 3 m (SAR) Radiated Measurements above 1 GHz, 3 m (FAR) Mains Ports Conducted Interference Measurements Telecommunication Ports Conducted Interference Measurem.	FCC, Federal Communications Commission Laboratory Division, USA (MRA US-EU 0003)
337 487 550 558	3462D-1 3462D-2 3462D-2 3462D-3	Radiated Measurements 30 MHz to 1 GHz, 3 m / 10 m (OATS) Radiated Measurements 30 MHz to 1 GHz, 3 m (SAR) Radiated Measurements 1 GHz to 6 GHz, 3 m (SAR) Radiated Measurements above 1 GHz, 3 m (FAR)	IC, Industry Canada Certification and Engineering Bureau
337 487 550 348	R-20013 G-20013 C-20009 T-20006	Radiated Measurements 30 MHz to 1 GHz, 3 m (SAR) Radiated Measurements 1 GHz to 6 GHz, 3 m (SAR) Mains Ports Conducted Interference Measurements Telecommunication Ports Conducted Interference Measurem.	VCCI, Voluntary Control Council for Interference by Information Technology Equipment, Japan
OATS	S = Open Area Te	est Site, SAR = Semi Anechoic Room, FAR = Fully Anechoic Room	



# 8. Instruments and Ancillary

## 8.1. Used equipment "CTC"

The "Ref.-No" in the left column of the following tables allows the clear identification of the laboratory equipment.

#### 8.1.1. Test software and firmware of equipment

RefNo.	Equipment	Туре	Serial-No.	Version of Firmware or Software during the test
001	EMI Test Receiver	ESS	825132/017	Firm.= 1.21, OTP=2.0, GRA=2.0
012	5	SMY 01	839069/027	Firm.= V 2.02
	Power Meter (EMS cond.)	NRVD	839111/003	Firm.= V 1.51
	Digital Radiocommunication Tester	CMD 60 M	844365/014	Firmware = V 3.52 .22.01.99, DECT = D2.87 13.01.99
053	Audio Analyzer	UPA3	860612/022	Firm. V 4.3
119	RT Harmonics Analyzer dig. Flickermeter	B10	G60547	Firm.= V 3.1DHG
140	Signal Generator	SMHU	831314/006	Firm.= 3.21
261	Thermal Power Sensor	NRV-Z55	825083/0008	EPROM-Datum 02.12.04, SE EE 1 B
262	Power Meter	NRV-S	825770/0010	Firm.= 2.6
263	Signal Generator	SMP 04	826190/0007	Firm.=3.21
264	Spectrum Analyzer	FSEK 30	826939/005	Bios=2.1, Analyzer= 3.20
295	Racal Digital Radio Test Set	6103	1572	UNIT Firmware= 4.04, SW-Main=4.04, SW-BBP=1.04, SW-DSP=1.02, Hardboot=1.02, Softboot=2.02
298	Univ. Radio Communication Tester	CMU 200	832221/091	R&S Test Firmware =3.53 /3.54 (current Testsoftw. f. all band used
323		CMD 55	825878/0034	Firm.= 3.52 .22.01.99
331	Climatic Test Chamber -40/+80 Grad	HC 4055	43146	TSI 1.53
335	CTC-EMS-Conducted	System EMS Conducted	-	EMC 32 V 8.52
	Digital Radiocommunication Tester	CMD 55	849709/037	Firm.= 3.52 .22.01.99
355	Power Meter	URV 5	891310/027	Firm.= 1.31
365	10V Insertion Unit 50 Ohm	URV5-Z2	100880	Eprom Data = 31.03.08
366	Ultra Compact Simulator	UCS 500 M4	V0531100594	Firm. UCS 500=001925/3.06a02, rc=ISMIEC 4.10
371	Bluetooth Tester	CBT32	100153	CBT V5,30+ SW-Option K55, K57
377	EMI Test Receiver	ESCS 30	100160	Firm.= 2.30, OTP= 02.01, GRA= 02.36
378	Broadband RF Field Monitor	RadiSense III	03D00013SNO-08	Firm.= V.03D13
389	Digital Multimeter	Keithley 2000	0583926	Firm. = A13 (Mainboard) A02 (Display)
392	Radio Communication Tester	MT8820A	6K00000788	Firm.= 4.50 #005, IPL=4.01#001,OS=4.02#001, GSM=4.41#013, W-CDMA= 4.54#004, scenario= 4.52#002
436	Univ. Radio Communication Tester	CMU 200	103083	R&S Test Firmware Base=5.14, Mess-Software= GSM:5.14 WCDMA:5.14 (current Testsoftw. F. all band
441	CTC-SAR-EMI Cable Loss	System EMI field (SAR)	-	EMC 32 Version 8.52
442	CTC-SAR-EMS	System EMS field (SAR)	-	EMC 32 Version 8.40
443	CTC-FAR-EMI-RSE	System CTC-FAR-EMI- RSE	-	Spuri 7.2.5 or EMC 32 Ver. 9.15.00
444	CTC-FAR-EMS field	System-EMS-Field (FAR)	-	EMC 32 Version 9.15.00
460	Univ. Radio Communication Tester	CMU 200	108901	R&S Test Firmware Base=5.14, GSM=5.14 WCDMA=5.14 (current Testsoftw.,f. all band to be used,
489	EMI Test Receiver	ESU40	1000-30	Firmware=4.43 SP3, Bios=V5.1-16-3, Spec. =01.00
491	ESD Simulator dito	ESD dito	dito307022	V 2.30
524	Voltage Drop Simulator	VDS 200	0196-16	Software Nr: 000037 Version V4.20a01
526	Burst Generator	EFT 200 A	0496-06	Software Nr. 000034 Version V2.32
527	Micro Pulse Generator	MPG 200 B	0496-05	Software-Nr. 000030 Version V2.43
528	Load Dump Simulator	LD 200B	0496-06	Software-Nr. 000031 Version V2.35a01
546	Univ. Radio Communication Tester	CMU 200	106436	R&S Test Firmware Base=5.14, GSM=5.14 WCDMA=5.14 (current Testsoftw.,f. all band to be used
547	Univ. Radio Communication Tester	CMU 200	835390/014	R&S Test Firmware Base=V5.1403 (current Testsoftw., f. all band used, GSM = 5.14 WCDMA: = 5.14
584	Spectrum Analyzer	FSU 8	100248	2.82_SP3
597	Univ. Radio Communication Tester	CMU 200	100347	R&S Test Firmware Base=5.01, GSM=5.02 WCDMA= not installed, Mainboard= µP1=V.850
598	Spectrum Analyzer	FSEM 30 (Reserve)	831259/013	Firmware Bios 3.40, Analyzer 3.40 Sp 2
620	EMI Test Receiver	ESU 26	100362	4.43 SP3
642	Wideband Radio Communication Tester	CMW 500	126089	Setup V03.26, Test programm component V03.02.20
692	Bluetooth Tester	CBT 32	100236	CBT V 5.40, FW: V.2.41 (FPGA Digital, V. 3.09 FPGA RF)



## 8.1.2. Single instruments and test systems

RefNo.	Equipment	Туре	Serial-No.	Manufacturer	Interval of calibration	Remark	Cal due
487	System CTC NSA-Verification SAR-EMI	System EMI field (SAR) NSA	-	ETS Lindgren / CETECOM	24 M	-	16.03.2021
468	Digital Multimeter	Fluke 112	90090455	Fluke USA	36 M	-	30.04.2021
802	Exposure Level Tester	ELT-400	O-0026	NARDA Safety Solutions	24 M	-	30.01.2021
803	Probe	ELT probe 3cm <sup>2</sup>	O-0026	Narda Safety Test Solution	24 M	-	30.01.2021
	Broadband Field Meter	NBM 550	A-0150	Narda Safety Test Solution	24 M	-	30.11.2019
	E-Field Probe	EF 0391	A-0124	Narda Safety Test Solution	24 M	-	30.11.2019

#### 8.1.3. Legend

Note / remarks		Calibrated during system calibration:
	1a	System CTC-SAR-EMS (RefNo. 442)
	1b	System-CTC-EMS-Conducted (RefNo. 335)
	1c	System CTC-FAR-EMI-RSE (RefNo . 443)
	1d	System CTC-SAR-EMI (RefNo . 441)
	1e	System CTC-OATS (EMI radiated) (RefNo. 337)
	1 f	System CTC-CTIA-OTA (RefNo . 420)
	1 g	System CTC-FAR-EMS (RefNo . 444)
	2	Calibration or equipment check immediately before measurement
	3	Regulatory maintained equipment for functional check or support purpose
	4	Ancillary equipment without calibration e.g. mechanical equipment or monitoring equipment
	5	Test System

Interval of calibration	12 M	12 month
	24 M	24 month
	36 M	36 month
	24/12 M Calibration every 24 months, between this every 12 months internal validation	
	36/12 M	Calibration every 36 months, between this every 12 months internal validation
	Pre-m	Check before starting the measurement
	-	Without calibration

# 9. Versions of test reports (change history)

Version	Applied changes	Date of release
	Initial release	2019-09-18

# **End of Test Report**